



Final Product Change Notification

201902019F01W

Issue Date: 06-Nov-2019
Effective Date: 04-Feb-2020

WITHDRAWAL

Here's your personalized quality information concerning products Digi-Key purchased from NXP.
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QUALITY

Management Summary

Wafer test, wafer map and PCM data transfer activities as well as finished goods testing is being moved from ATKH to ATBK. Product has been qualified on the SPEA (ATBK) due to STS decommission (ATKH)

Change Category

- | | | | | |
|--|---|--|---|---|
| <input type="checkbox"/> Wafer Fab Process | <input type="checkbox"/> Assembly Process | <input type="checkbox"/> Product Marking | <input checked="" type="checkbox"/> Test Location | <input type="checkbox"/> Design |
| <input type="checkbox"/> Wafer Fab Materials | <input type="checkbox"/> Assembly Materials | <input type="checkbox"/> Mechanical Specification | <input type="checkbox"/> Test Process | <input type="checkbox"/> Errata |
| <input type="checkbox"/> Wafer Fab Location | <input type="checkbox"/> Assembly Location | <input type="checkbox"/> Packing/Shipping/Labeling | <input type="checkbox"/> Test Equipment | <input type="checkbox"/> Electrical spec./Test coverage |
| <input type="checkbox"/> Firmware | <input type="checkbox"/> Other | | | |

Withdrawal Notification: PCA8565AU
Wafer and PCA8565TS/1 Test
Transfer from ATKH to ATBK

Description of Change

Withdrawal of Change: Move all of electrical wafer testing and final testing of PCA8565TS/1 from ATKH (STS platform) to ATBK (SPEA test platform).

See withdrawal information below.

Reason for Change

Test platform improvement allowing for less downtime.

Identification of Affected Products

Product identification does not change

Product Availability

Sample Information

Samples are available from 05-Apr-2019

Production

Planned first shipment 22-May-2019

Withdrawal Information

Original plan for final test site change from ATKH to ATBK for PCA8565AU/5BB/1 has been cancelled. Final testing of PCA8565TS/1 has always been in ATBK, therefore there is no change of test site.

Anticipated Impact on Form, Fit, Function, Reliability or Quality

No impact on form, fit, function, reliability or quality.

Disposition of Old Products

Existing inventory will be shipped until depleted

Timing and Logistics

In compliance with JEDEC J-STD-046, your acknowledgement of this change is expected by 06-Dec-2019.

Contact and Support

For all inquiries regarding the ePCN tool application or access issues, please contact NXP "Global Quality Support Team".

For all Quality Notification content inquiries, please contact your local NXP Sales Support team.

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NXP Quality Management Team.

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Affected Part Number

PCA8565TS/1,118